## Applicant(s)/Patent Under Application/Control No. Reexamination 10/633,190 CHANG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2653 Mark Blouin **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 360/265.7 US-2003/0076633 A1 04-2003 Macpherson et al. 360/244.6 US-6,728,072 B1 04-2004 Van Sloun et al. В 360/245.9 10-2003 Chew, David W. US-6,636,383 B1 С US-D US-Ε US-F US-G US-Н US-1 US- · J US-Κ US-L US-FOREIGN PATENT DOCUMENTS **Document Number** Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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